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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/830,173	KIM ET AL.	
Examiner	Art Unit	
John L. Goodrow	1756	

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Class	Subclass	Date	Examiner
430	108.4	4/14/2006	JG
	108.8		
	110.1		
	110.2		
	110.4		
	111.4		
	137.11		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCI)
	DATE	EXMR
inventor name search and east	4/14/2006	JG